

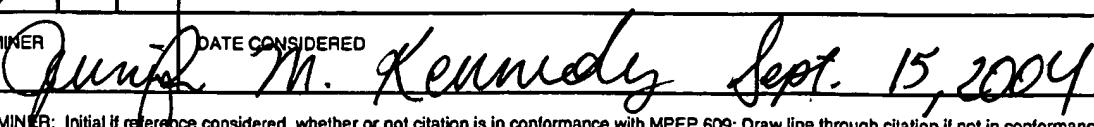
12/30 IDS Y1

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Form PTO-1449		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE			ATTY. DOCKET NO. MI22-2477	PRIORITY SERIAL NO. 10/051,981	
LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)					APPLICANT: Zhongze Wang 1D/749,659		
					PRIORITY FILING DATE January 16, 2002	PRIORITY GROUP ART UNIT 2812	
U.S. PATENT DOCUMENTS							
Examiner's Initials		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
QH	AA	5,021,843	06/1991	Ohmi			
QH	AB	5,849,627	12/1998	Linn et al.			
QH	AC	6,010,921	01/00	Soutome			
QH	AD	6,255,731 B1	07/2001	Ohmi et al.			
QH	AE	6,410,938 B1	06/2002	Xiang			
QH	AF	6,433,401 B1	08/2002	Clark et al.			
QH	AO	6,610,615 B1	08/2003	McFadden et al.			
QH	AH	2002/0134503 A1	02/2002	Hussinger et al.			
	AL						
FOREIGN PATENT DOCUMENTS							
		Document Number	Date	Country	Class	Subclass	Translation
	AJ						Yes
	AK						No
	AL						
OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)							
YL	AM		Bernstein et al., <i>Floating Body Effects, SOI DEVICE ELECTRICAL PROPERTIES</i> 34-53 (pre-August 2001).				
	AN						
	AO						
EXAMINER		DATE CONSIDERED					
Jenni M. Kennedy		Sept. 15, 2004					
*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							

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Sheet 1 of 1

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					FILING DATE 12/30/2003		GROUP 2812	
U.S. PATENT DOCUMENTS								
*Examiner's Initials		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate	
Off	AA	6,552,496 B2	04/2003	Yamazaki	315	169.3		
Off	AB	5,882,532	03/1999	Field et al.	216	2		
Off	AC	6,265,327	07/2001	Kobayashi et al.	438	776		
	AD							
	AE							
	AF							
	AG							
	AH							
	AI							
FOREIGN PATENT DOCUMENTS								
		Document Number	Date	Country	Class	Subclass	Translation	
	AJ						Yes	No
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Form PTO-1449		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE			ATTY. DOCKET NO. MI22-2477		SERIAL NO. 10/749,659		
 LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)					APPLICANT: Zhongze Wang				
		FILING DATE 12/30/2003		GROUP 2811					
SEARCHED DOCUMENTS									
*Examiner's Initials		Document Number	Date	Name		Class	Subclass	Filing Date if Appropriate	
<i>JL</i>	AA	6,512,244 B1	01/2003	Ju et al.		257	59		
<i>JL</i>	AB	6,509,613 B1	01/2003	En et al.		257	349		
<i>JL</i>	AC	6,541,861 B2	04/2003	Higashi et al.		257	751		
<i>JM</i>	AD	6,680,243 B1	01/2004	Kamath et al.		438	526		
<i>JL</i>	AE	6,531,375 B1	03/2003	Giewont et al.		438	407		
<i>JL</i>	AF	6,661,065 B2	12/2003	Kunikiyo		257	411		
<i>JL</i>	AG	5,773,355	06/1998	Inoue et al.		438	459		
<i>JL</i>	AH	5,767,020	06/1998	Sakaguchi et al.		438	705		
<i>JL</i>	AI	6,534,380 B1	03/2003	Yamauchi et al.		438	455		
FOREIGN PATENT DOCUMENTS									
		Document Number	Date	Country		Class	Subclass	Translation	
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	AK								
	AL								
OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)									
	AM								
	AN								
	AO								
EXAMINER		DATE CONSIDERED							
<i>James M. Kennedy</i>		Sept. 15, 2004							
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U.S. PATENT DOCUMENTS								
*Examiner's Initials		Document Number	Date	Name		Class	Subclass	Filing Date if Appropriate
<i>AM</i>	<i>AM</i>	5,374,329	12/1994	Miyawaki		156	630	
<i>AM</i>	<i>AB</i>	2002/0070454 A1	06/2002	Yasukawa		257	760	
<i>AM</i>	<i>AC</i>	2002/0011670 A1	01/2002	Higashi et al.		257	751	
<i>AM</i>	<i>AD</i>	2001/0020722 A1	09/2001	Yang		257	347	
<i>AM</i>	<i>AE</i>	2003/0085424 A1	05/2003	Bryant et al.		257	347	
<i>AM</i>	<i>AF</i>	6,313,014 B1	11/2001	Sakaguchi et al.		438	475	
<i>AM</i>	<i>AG</i>	6,350,703 B1	02/2002	Sakaguchi et al.		438	766	
<i>AM</i>	<i>AH</i>	5,453,394	09/1995	Yonehara et al.		437	62	
<i>AM</i>	<i>AI</i>	5,405,802	04/1995	Yamagata et al.		437	71	
FOREIGN PATENT DOCUMENTS								
		Document Number	Date	Country	Class	Subclass	Translation	
							Yes	No
	<i>AM</i>							
	<i>AK</i>							
	<i>AL</i>							
OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)								
	<i>AM</i>							
	<i>AM</i>							
	<i>AO</i>							
EXAMINER	<i>James M. Kennedy Sept. 15, 2004</i>							
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Opd	AA	6,037,634	03/2000	Akiyama		257	347		
Opd	AB	5,841,171	11/1998	Iwamatsu et al.		257	347		
Opd	AC	5,910,672	06/1999	Iwamatsu et al.		257	347		
Opd	AD	5,670,411	09/1997	Yonehara et al.		437	62		
	AE								
	AF								
	AG								
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	AI								
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